

Notice of References Cited		Application/Control No. 10/591,235	Applicant(s)/Patent Under Reexamination LUKE, STEFAN	
		Examiner CUONG H. NGUYEN	Art Unit 3661	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2007/0282503	12-2007	Luke, Stefan	701/044
*	B	US-7,165,644	01-2007	Offerle et al.	180/244
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
*	U	Experimental Investigation of a Narrow Leaning Vehicle Tilt Stability Control System; Kidane, S.; Rajamani, R.; Alexander, L.; Starr, P.; Donath, M.; American Control Conference, 2007. ACC '07; 9-13 July 2007 Page(s):1612 - 1617; Digital Object Identifier 10.1109/ACC.2007.4282625			
*	V	Electric motor based steering for jackknife avoidance in large trucks; McCann, R.; Le, A.; Vehicle Power and Propulsion, 2005 IEEE Conference; 7-9 Sept. 2005 Page(s):7 pp. ; Digital Object Identifier 10.1109/VPPC.2005.1554540			
*	W	Traction control of wheeled vehicles using dynamic feedback approach; Sarkar, N.; Xiaoping Yun; Intelligent Robots and Systems, 1998. Proceedings., 1998 IEEE/RSJ International Conference on; Volume 1, 13-17 Oct. 1998 Page(s):413 - 418 vol.1 Digital Object Identifier 10.1109/IROS.1998.724654			
*	X	J. Pohl, M. Sethsson, P. Degerman, J. Larsson; A semi-automated parallel parking system for passenger cars; Journal: Proceedings of the Institution of Mechanical Engineers, Part D: Journal of Automobile Engineering; Publisher: Professional Engineering Publishing; ISSN 0954-4070 , Volume 220, Number 1 / 2006			

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.